# **BYV32EB-200**

## Dual rugged ultrafast rectifier diode, 20 A, 200 V

Rev. 04 — 2 March 2009

**Product data sheet** 

## 1. Product profile

### 1.1 General description

Ultrafast dual epitaxial rectifier diode in a SOT404 (D2PAK) surface-mountable plastic package.

### 1.2 Features and benefits

- High reverse voltage surge capability
- High thermal cycling performance
- Low thermal resistance

- Soft recovery characteristic minimizes power consuming oscillations
- Surface-mountable package
- Very low on-state loss

## 1.3 Applications

 Output rectifiers in high-frequency switched-mode power supplies

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{RRM}$	repetitive peak reverse voltage		-	-	200	V
$I_{O(AV)}$	average output current	square-wave pulse; $\delta$ = 0.5; $T_{mb} \le 115$ °C; both diodes conducting; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	20	Α
I <sub>RRM</sub>	repetitive peak reverse current	$t_p = 2 \ \mu s; \ \delta = 0.001$	-	-	0.2	Α
$V_{ESD}$	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins	-	-	8	kV
Dynamic	characteristics					
t <sub>rr</sub>	reverse recovery time	$I_F = 1 \text{ A}$ ; $V_R = 30 \text{ V}$ ; $dI_F/dt = 100 \text{ A/}\mu\text{s}$ ; $T_j = 25 \text{ °C}$ ; ramp recovery; see Figure 5	-	20	25	ns
		$I_R$ = 1 A; $I_F$ = 0.5 A; $T_j$ = 25 °C; measured at reverse current = 0.25 A; step recovery; see Figure 6	-	10	20	ns
Static ch	aracteristics					
$V_{F}$	forward voltage	$I_F = 8 \text{ A}; T_j = 150 \text{ °C}; \text{ see } \frac{\text{Figure 4}}{}$	-	0.72	0.85	V



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## **Pinning information**

Table 2. **Pinning information** 

Pin	Symbol	Description		Simplified outline	Graphic symbol
1	A1	anode 1			
2	K	cathode	[1]	mb	A1
3	A2	anode 2			<u> </u>
mb	К	mounting base; cathode		1 3	sym125
				SOT404 (D2PAK)	

[1] it is not possible to make a connection to pin 2 of the SOT404 package

## **Ordering information**

Table 3. **Ordering information** 

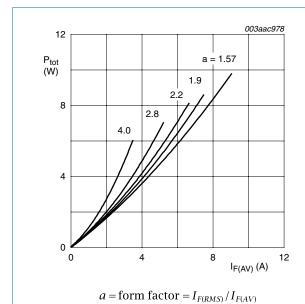
Type number	Package		
	Name	Description	Version
BYV32EB-200	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

## **Limiting values**

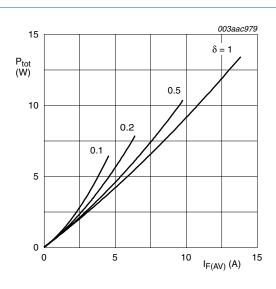
Table 4. **Limiting values** 

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{RRM}$	repetitive peak reverse voltage		-	200	V
$V_{RWM}$	crest working reverse voltage		-	200	V
$V_R$	reverse voltage	DC	-	200	V
I <sub>O(AV)</sub>	average output current	square-wave pulse; $\delta$ = 0.5; $T_{mb} \le$ 115 °C; both diodes conducting; see Figure 1; see Figure 2	-	20	Α
I <sub>FRM</sub>	repetitive peak forward current	$\bar{\delta}$ = 0.5; $t_p$ = 25 $\mu$ s; $T_{mb}$ ≤ 115 °C; per diode	-	20	Α
I <sub>FSM</sub>	non-repetitive peak forward current	$t_p$ = 8.3 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	137	Α
		$t_p$ = 10 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	125	Α
I <sub>RRM</sub>	repetitive peak reverse current	$\delta$ = 0.001; $t_p$ = 2 $\mu$ s	-	0.2	Α
I <sub>RSM</sub>	non-repetitive peak reverse current	$t_p = 100 \ \mu s$	-	0.2	Α
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	150	°C
V <sub>ESD</sub>	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins	-	8	kV



Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values



 $I_{F(AV)} = I_{F(RMS)} \times \sqrt{\delta}$ 

Forward power dissipation as a function of Fig 2. average forward current; square waveform; maximum values

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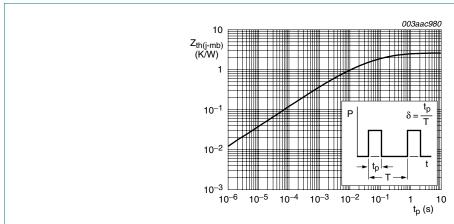
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## Thermal characteristics

**Thermal characteristics** Table 5.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting	with heatsink compound; both diodes conducting	-	-	1.6	K/W
	base	with heatsink compound; per diode; see Figure 3	-	-	2.4	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint FR4 board	-	50	-	K/W

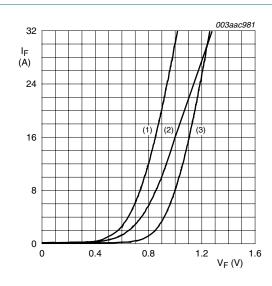


Transient thermal impedance from junction to mounting base as a function of pulse width Fig 3.

## **Characteristics**

Table 6. **Characteristics** 

10010 01	On an actor lotico					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V <sub>F</sub>	forward voltage	$I_F = 8 \text{ A}; T_j = 150 \text{ °C}; \text{ see } \frac{\text{Figure 4}}{\text{Minimum Figure 4}}$	-	0.72	0.85	V
		I <sub>F</sub> = 20 A; T <sub>j</sub> = 25 °C	-	1	1.15	V
I <sub>R</sub>	reverse current	V <sub>R</sub> = 200 V; T <sub>j</sub> = 25 °C	-	6	30	μΑ
		V <sub>R</sub> = 200 V; T <sub>j</sub> = 100 °C	-	0.2	0.6	mA
Dynamic	characteristics					
$Q_r$	recovered charge	$I_F = 2 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 20 \text{ A/}\mu\text{s}$	-	8	12.5	nC
t <sub>rr</sub>	reverse recovery time	$I_F = 1 \text{ A}$ ; $V_R = 30 \text{ V}$ ; $dI_F/dt = 100 \text{ A/}\mu\text{s}$ ; ramp recovery; $T_j = 25 ^{\circ}\text{C}$ ; see Figure 5	-	20	25	ns
		$I_F$ = 0.5 A; $I_R$ = 1 A; measured at reverse current = 0.25 A; step recovery; $T_j$ = 25 °C; see Figure 6	-	10	20	ns
$V_{FR}$	forward recovery voltage	$I_F = 1 \text{ A}$ ; $dI_F/dt = 10 \text{ A/}\mu\text{s}$ ; see Figure 7	-	-	1	V
' <u>'</u>		· · · · · · · · · · · · · · · · · · ·	·	•	· ·	· ·



- (1)  $T_j = 150$  °C; typical values
- (2)  $T_j = 150 \, ^{\circ}C$ ; maximum values
- (3)  $T_j = 25$  °C; maximum values

Forward current as a function of forward Fig 4. voltage

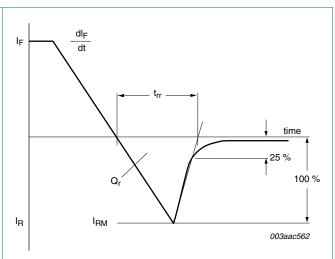
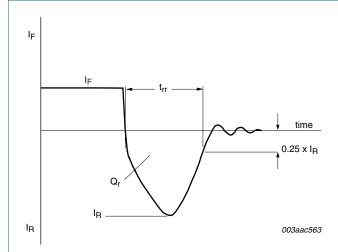
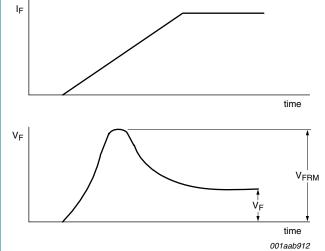


Fig 5. Reverse recovery definitions; ramp recovery



Reverse recovery definitions; step recovery

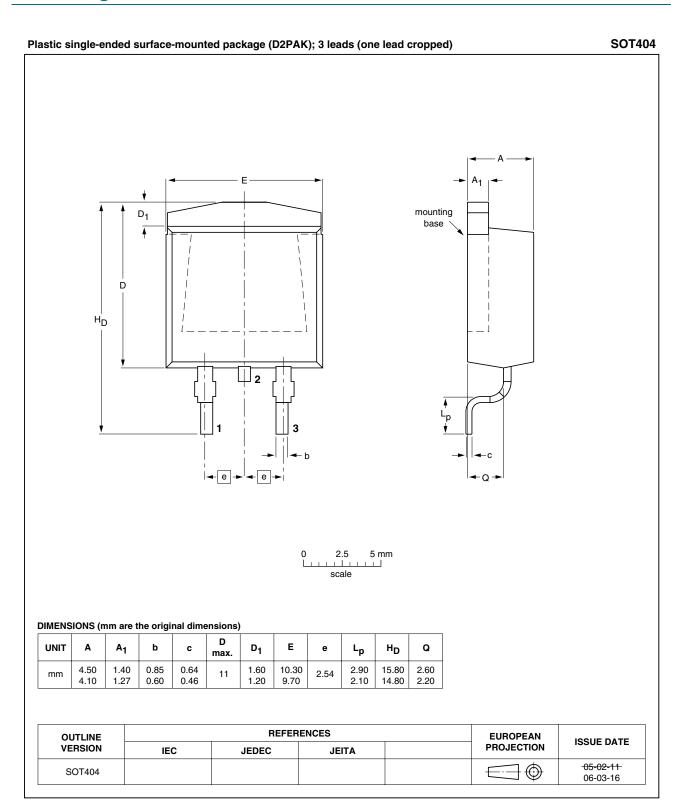


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Fig 7. Forward recovery definitions

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## 7. Package outline



Package outline SOT404 (D2PAK)

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## 8. Revision history

#### Table 7. Revision history

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Document ID	Release date	Data sheet status	Change notice	Supersedes
BYV32EB-200_4	20090302	Product data sheet	-	BYV32E_SERIES_3
Modifications:		of this data sheet has be of NXP Semiconductors.	en redesigned to compl	y with the new identity
	<ul> <li>Legal texts</li> </ul>	have been adapted to th	e new company name w	here appropriate.
	<ul> <li>Package o</li> </ul>	utline updated.		
	<ul> <li>Type numb</li> </ul>	er BYV32EB-200 separa	ted from data sheet BY\	/32E_SERIES_3
BYV32E_SERIES_3	20010301	Product specification	-	BYV32E_SERIES_2
BYV32E_SERIES_2	19980701	Product specification	-	BYV32EB_SERIES_1
BYV32EB_SERIES_1	19960801	Product specification	-	-

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#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Date of release: 2 March 2009 Document identifier: BYV32EB-200\_4

